Welcome to E-XFL.COM

What is "Embedded - Microcontrollers"?

"Embedded - Microcontrollers" refer to small, integrated circuits designed to perform specific tasks within larger systems. These microcontrollers are essentially compact computers on a single chip, containing a processor core, memory, and programmable input/output peripherals. They are called "embedded" because they are embedded within electronic devices to control various functions, rather than serving as standalone computers. Microcontrollers are crucial in modern electronics, providing the intelligence and control needed for a wide range of applications.

Applications of "Embedded - Microcontrollers"

Details	
Product Status	Active
Core Processor	AVR
Core Size	32-Bit Single-Core
Speed	66MHz
Connectivity	CANbus, EBI/EMI, Ethernet, I²C, IrDA, LINbus, SPI, UART/USART, USB
Peripherals	Brown-out Detect/Reset, DMA, I²S, POR, PWM, WDT
Number of I/O	123
Program Memory Size	256KB (256K x 8)
Program Memory Type	FLASH
EEPROM Size	-
RAM Size	64K x 8
Voltage - Supply (Vcc/Vdd)	3V ~ 5.5V
Data Converters	A/D 16x12b; D/A 4x12b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 85°C (TA)
Mounting Type	Surface Mount
Package / Case	144-LQFP
Supplier Device Package	144-LQFP (20x20)
Purchase URL	https://www.e-xfl.com/product-detail/microchip-technology/at32uc3c0256c-alur

- One 4-Channel 20-bit Pulse Width Modulation Controller (PWM)
  - Complementary outputs, with Dead Time Insertion
  - Output Override and Fault Protection
- Two Quadrature Decoders
- One 16-channel 12-bit Pipelined Analog-To-Digital Converter (ADC)
  - Dual Sample and Hold Capability Allowing 2 Synchronous Conversions
  - Single-Ended and Differential Channels, Window Function
- Two 12-bit Digital-To-Analog Converters (DAC), with Dual Output Sample System
- Four Analog Comparators
- Six 16-bit Timer/Counter (TC) Channels
  - External Clock Inputs, PWM, Capture and Various Counting Capabilities
- One Peripheral Event Controller
  - Trigger Actions in Peripherals Depending on Events Generated from Peripherals or from Input Pins
  - Deterministic Trigger
  - 34 Events and 22 Event Actions
- Five Universal Synchronous/Asynchronous Receiver/Transmitters (USART)
  - Independent Baudrate Generator, Support for SPI, LIN, IrDA and ISO7816 interfaces
  - Support for Hardware Handshaking, RS485 Interfaces and Modem Line
- Two Master/Slave Serial Peripheral Interfaces (SPI) with Chip Select Signals
- One Inter-IC Sound (I2S) Controller
  - Compliant with I2S Bus Specification
  - Time Division Multiplexed mode
- Three Master and Three Slave Two-Wire Interfaces (TWI), 400kbit/s I^2C-compatible
- QTouch® Library Support
  - Capacitive Touch Buttons, Sliders, and Wheels
  - QTouch® and QMatrix® Acquisition
- On-Chip Non-intrusive Debug System
  - Nexus Class 2+, Runtime Control, Non-Intrusive Data and Program Trace
  - aWire™ single-pin programming trace and debug interface muxed with reset pin
  - NanoTrace™ provides trace capabilities through JTAG or aWire interface
- 3 package options
  - 64-pin QFN/TQFP (45 GPIO pins)
  - 100-pin TQFP (81 GPIO pins)
  - 144-pin LQFP (123 GPIO pins)
- Two operating voltage ranges:
  - Single 5V Power Supply
  - Single 3.3V Power Supply

2. Overview

2.1 Block diagram

Figure 2-1. Block diagram

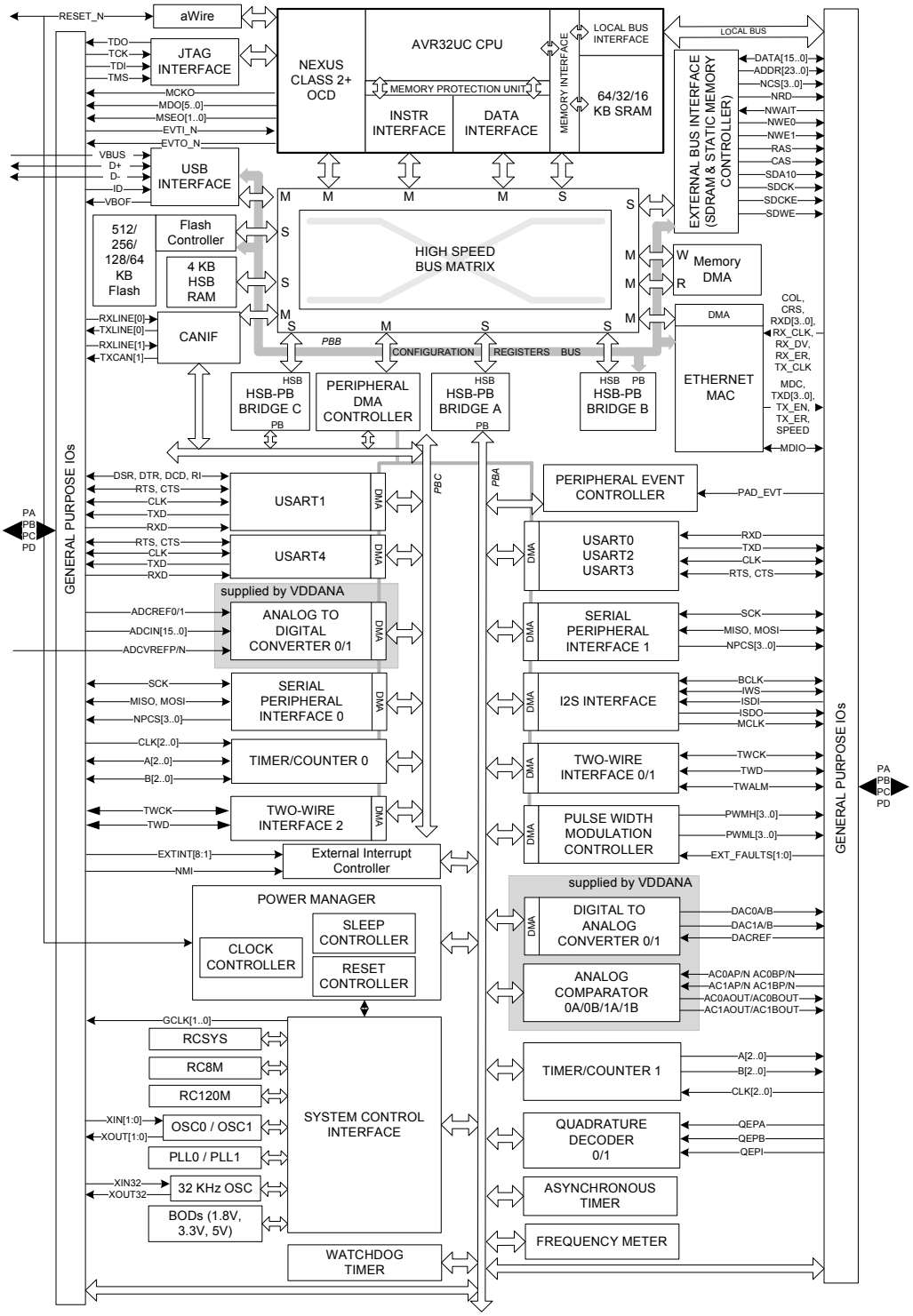


Table 2-1. Configuration Summary

Feature	AT32UC3C0512C/ AT32UC3C0256C/ AT32UC3C0128C/ AT32UC3C064C	AT32UC3C1512C/ AT32UC3C1256C/ AT32UC3C1128C/ AT32UC3C164C	AT32UC3C2512C/ AT32UC3C2256C/ AT32UC3C2128C/ AT32UC3C264C
Analog Comparators	4	4	2
JTAG	1		
aWire	1		
Max Frequency	66 MHz		
Package	LQFP144	TQFP100	TQFP64/QFN64

Figure 3-2. TQFP100 Pinout

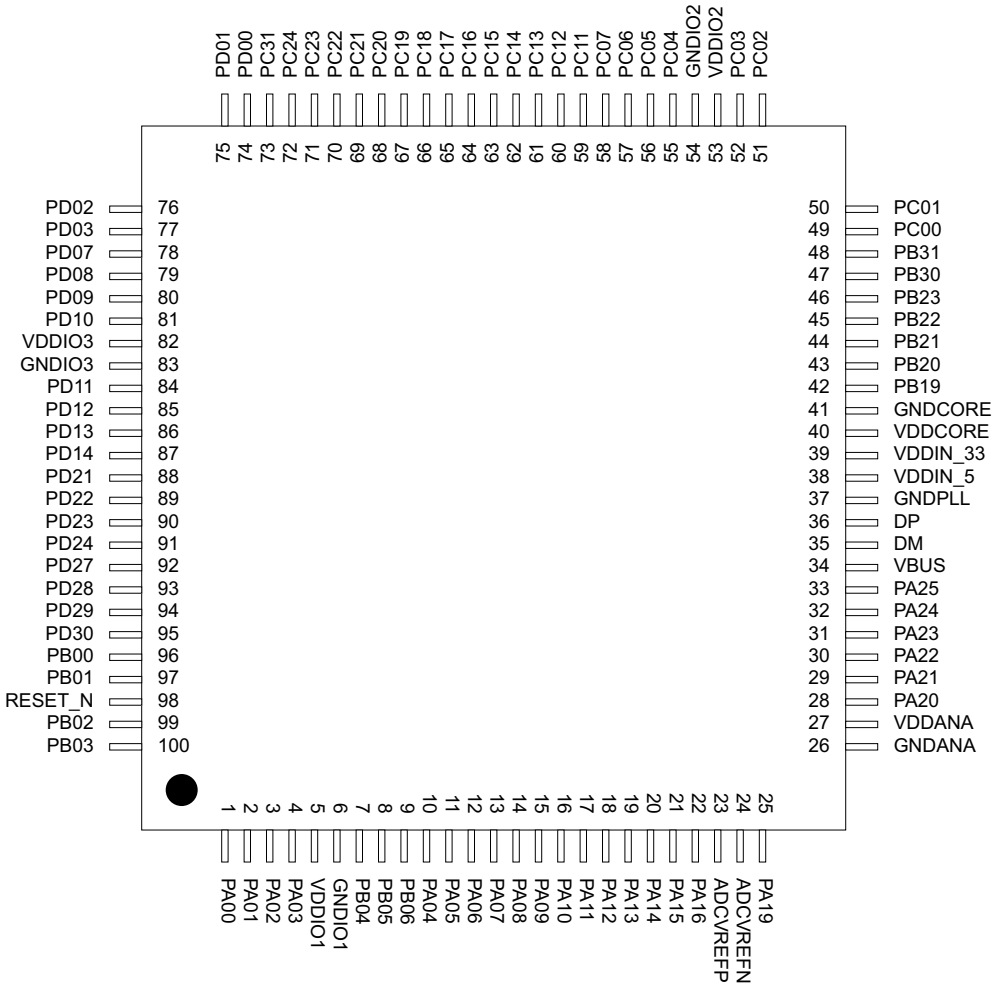


Table 3-7. Signal Description List

Signal Name	Function	Type	Active Level	Comments
SDCK	SDRAM Clock	Output		
SDCKE	SDRAM Clock Enable	Output		
SDWE	SDRAM Write Enable	Output	Low	
External Interrupt Controller - EIC				
EXTINT[8:1]	External Interrupt Pins	Input		
NMI_N = EXTINT[0]	Non-Maskable Interrupt Pin	Input	Low	
General Purpose Input/Output - GPIOA, GPIOB, GPIOC, GPIOD				
PA[29:19] - PA[16:0]	Parallel I/O Controller GPIOA	I/O		
PB[31:0]	Parallel I/O Controller GPIOB	I/O		
PC[31:0]	Parallel I/O Controller GPIOC	I/O		
PD[30:0]	Parallel I/O Controller GPIOD	I/O		
Inter-IC Sound (I2S) Controller - IISC				
IMCK	I2S Master Clock	Output		
ISCK	I2S Serial Clock	I/O		
ISDI	I2S Serial Data In	Input		
ISDO	I2S Serial Data Out	Output		
IWS	I2S Word Select	I/O		
JTAG				
TCK	Test Clock	Input		
TDI	Test Data In	Input		
TDO	Test Data Out	Output		
TMS	Test Mode Select	Input		
Ethernet MAC - MACB				
COL	Collision Detect	Input		
CRS	Carrier Sense and Data Valid	Input		
MDC	Management Data Clock	Output		
MDIO	Management Data Input/Output	I/O		
RXD[3:0]	Receive Data	Input		

Table 3-7. Signal Description List

Signal Name	Function	Type	Active Level	Comments
NPCS[3:0]	SPI Peripheral Chip Select	I/O	Low	
SCK	Clock	Output		
Timer/Counter - TC0, TC1				
A0	Channel 0 Line A	I/O		
A1	Channel 1 Line A	I/O		
A2	Channel 2 Line A	I/O		
B0	Channel 0 Line B	I/O		
B1	Channel 1 Line B	I/O		
B2	Channel 2 Line B	I/O		
CLK0	Channel 0 External Clock Input	Input		
CLK1	Channel 1 External Clock Input	Input		
CLK2	Channel 2 External Clock Input	Input		
Two-wire Interface - TWIMS0, TWIMS1, TWIMS2				
TWALM	SMBus SMBALERT	I/O	Low	Only on TWIMS0, TWIMS1
TWCK	Serial Clock	I/O		
TWD	Serial Data	I/O		
Universal Synchronous Asynchronous Receiver Transmitter - USART0, USART1, USART2, USART3, USART4				
CLK	Clock	I/O		
CTS	Clear To Send	Input	Low	
DCD	Data Carrier Detect	Input	Low	Only USART1
DSR	Data Set Ready	Input	Low	Only USART1
DTR	Data Terminal Ready	Output	Low	Only USART1
RI	Ring Indicator	Input	Low	Only USART1
RTS	Request To Send	Output	Low	
RXD	Receive Data	Input		
TXD	Transmit Data	Output		
Universal Serial Bus Device - USB				
DM	USB Device Port Data -	Analog		

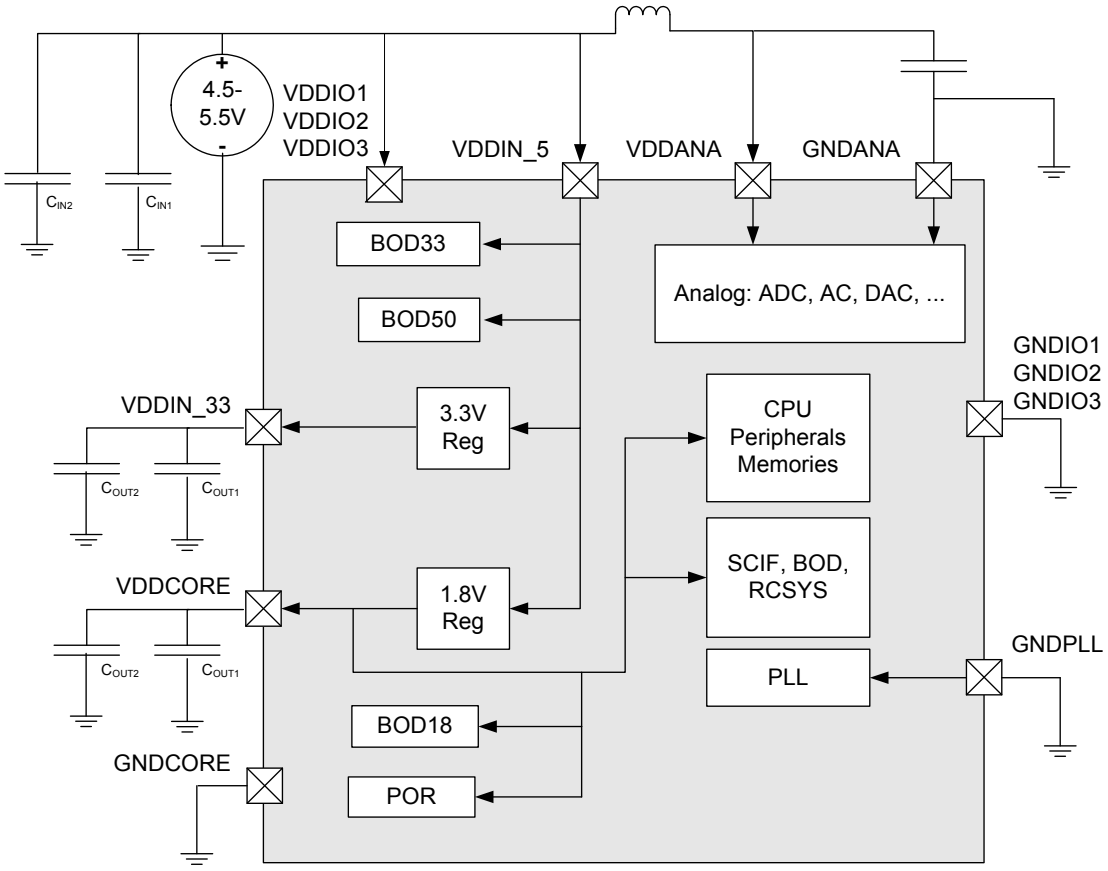
Table 5-3. Peripheral Address Mapping

0xFFFE0000	HFLASHC	Flash Controller - HFLASHC
0xFFFE1000	USBC	USB 2.0 OTG Interface - USBC
0xFFFE2000	HMATRIX	HSB Matrix - HMATRIX
0xFFFE2400	SAU	Secure Access Unit - SAU
0xFFFE2800	SMC	Static Memory Controller - SMC
0xFFFE2C00	SDRAMC	SDRAM Controller - SDRAMC
0xFFFE3000	MACB	Ethernet MAC - MACB
0xFFFF0000	INTC	Interrupt controller - INTC
0xFFFF0400	PM	Power Manager - PM
0xFFFF0800	SCIF	System Control Interface - SCIF
0xFFFF0C00	AST	Asynchronous Timer - AST
0xFFFF1000	WDT	Watchdog Timer - WDT
0xFFFF1400	EIC	External Interrupt Controller - EIC
0xFFFF1800	FREQM	Frequency Meter - FREQM
0xFFFF2000	GPIO	General Purpose Input/Output Controller - GPIO
0xFFFF2800	USART0	Universal Synchronous/Asynchronous Receiver/Transmitter - USART0
0xFFFF2C00	USART2	Universal Synchronous/Asynchronous Receiver/Transmitter - USART2
0xFFFF3000	USART3	Universal Synchronous/Asynchronous Receiver/Transmitter - USART3
0xFFFF3400	SPI1	Serial Peripheral Interface - SPI1

The 3.3V regulator is connected to the 5V source (VDDIN_5 pin) and its output feeds the USB pads. If the USB is not used, the 3.3V regulator can be disabled through the VREG33CTL field of the VREGCTRL SCIF register.

Figure 6-1 on page 47 shows the power schematics to be used for 5V single supply mode. All I/O lines and analog blocks will be powered by the same power (VDDIN_5 = VDDIO1 = VDDIO2 = VDDIO3 = VDDANA).

Figure 6-1. 5V Single Power Supply mode



6.1.3.2 *3.3V Single Supply Mode*

In 3.3V single supply mode, the VDDIN_5 and VDDIN_33 pins should be connected together externally. The 1.8V internal regulator is connected to the 3.3V source (VDDIN_5 pin) and its output feeds VDDCORE.

The 3.3V regulator should be disabled once the circuit is running through the VREG33CTL field of the VREGCTRL SCIF register.

Figure 6-2 on page 48 shows the power schematics to be used for 3.3V single supply mode. All I/O lines and analog blocks will be powered by the same power (VDDIN_5 = VDDIN_33 = VDDIO1 = VDDIO2 = VDDIO3 = VDDANA).

Table 7-2. Supply Rise Rates and Order

Symbol	Parameter	Rise Rate		
		Min	Max	Comment
V_{VDDIN_5}	DC supply internal 3.3V regulator	0.01 V/ms	1.25 V/us	
V_{VDDIN_33}	DC supply internal 1.8V regulator	0.01 V/ms	1.25 V/us	
V_{VDDIO1} V_{VDDIO2} V_{VDDIO3}	DC supply peripheral I/O	0.01 V/ms	1.25 V/us	Rise after or at the same time as VDDIN_5, VDDIN_33
V_{VDDANA}	DC supply peripheral I/O and analog part	0.01 V/ms	1.25 V/us	Rise after or at the same time as VDDIN_5, VDDIN_33

7.3 Maximum Clock Frequencies

These parameters are given in the following conditions:

- $V_{VDDCORE}$ > 1.85V
- Temperature = -40°C to 85°C

Table 7-3. Clock Frequencies

Symbol	Parameter	Conditions	Min	Max	Units
f_{CPU}	CPU clock frequency			66	MHz
f_{PBA}	PBA clock frequency			66	MHz
f_{PBB}	PBB clock frequency			66	MHz
f_{PBC}	PBC clock frequency			66	MHz
f_{GCLK0}	GCLK0 clock frequency	Generic clock for USBC		50(1)	MHz
f_{GCLK1}	GCLK1 clock frequency	Generic clock for CANIF		66(1)	MHz
f_{GCLK2}	GCLK2 clock frequency	Generic clock for AST		80(1)	MHz
f_{GCLK4}	GCLK4 clock frequency	Generic clock for PWM		133(1)	MHz
f_{GCLK11}	GCLK11 clock frequency	Generic clock for IISC		50(1)	MHz

Note: 1. These values are based on simulation and characterization of other AVR microcontrollers manufactured in the same process technology. These values are not covered by test limits in production.

7.4 Power Consumption

The values in Table 7-4 are measured values of power consumption under the following conditions, except where noted:

- Operating conditions core supply (Figure 7-1)
  - V_{VDDIN_5} = V_{VDDIN_33} = 3.3V
  - $V_{VDDCORE}$ = 1.85V, supplied by the internal regulator
  - V_{VDDIO1} = V_{VDDIO2} = V_{VDDIO3} = 3.3V
  - V_{VDDANA} = 3.3V

  - PLL1 stopped
- Clocks
  - External clock on XIN0 as main clock source.
  - CPU, HSB, and PB clocks undivided

Consumption active is the added current consumption when the module clock is turned on and when the module is doing a typical set of operations.

Table 7-5. Typical Current Consumption by Peripheral[2]

Peripheral	Typ Consumption Active	Unit
ACIFA[1]	3	µA/MHz
ADCIFA[1]	7	
AST	3	
CANIF	25	
DACIFB[1]	3	
EBI	23	
EIC	0.5	
FREQM	0.5	
GPIO	37	
INTC	3	
MDMA	4	
PDCA	24	
PEVC	15	
PWM	40	
QDEC	3	
SAU	3	
SDRAMC	2	
SMC	9	
SPI	5	
TC	8	
TWIM	2	
TWIS	2	
USART	10	
USBC	5	
WDT	2	

Notes: 1. Includes the current consumption on VDDANA.
2. These numbers are valid for the measured condition only and must not be extrapolated to other frequencies.

7.7 Flash Characteristics

Table 7-15 gives the device maximum operating frequency depending on the number of flash wait states. The FSW bit in the FLASHC FSR register controls the number of wait states used when accessing the flash memory.

Table 7-15. Maximum Operating Frequency

Flash Wait States	Read Mode	Maximum Operating Frequency
0	1 cycle	33 MHz
1	2 cycles	66 MHz

Table 7-16. Flash Characteristics

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
t_{FPP}	Page programming time	f_{CLK_HSB} = 66 MHz		4.3		ms
t_{FPE}	Page erase time			4.3		
t_{FFP}	Fuse programming time			0.6		
t_{FEA}	Full chip erase time (EA)			4.9		
t_{FCE}	JTAG chip erase time (CHIP_ERASE)	f_{CLK_HSB} = 115 kHz		640		

Table 7-17. Flash Endurance and Data Retention

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
N_{FARRAY}	Array endurance (write/page)		100k			cycles
N_{FFUSE}	General Purpose fuses endurance (write/bit)		1k			cycles
t_{RET}	Data retention		15			years

7.8 Analog Characteristics

7.8.1 1.8V Voltage Regulator Characteristics

Table 7-18. 1.8V Voltage Regulator Electrical Characteristics

Symbol	Parameter	Condition	Min	Typ	Max	Units
V_{VDDIN_5}	Input voltage range	5V range	4.5		5.5	V
		3V range	3.0		3.6	
$V_{VDDCORE}$	Output voltage, calibrated value			1.85		V
I_{OUT}	DC output current				80	mA

Table 7-19. Decoupling Requirements

Symbol	Parameter	Condition	Typ	Techno.	Units
C_{IN1}	Input regulator capacitor 1		1	NPO	nF
C_{IN2}	Input regulator capacitor 2		4.7	X7R	uF
C_{OUT1}	Output regulator capacitor 1		470	NPO	pf
C_{OUT2}	Output regulator capacitor 2		2.2	X7R	uF

7.8.2 3.3V Voltage Regulator Characteristics

Table 7-20. 3.3V Voltage Regulator Electrical Characteristics

Symbol	Parameter	Condition	Min	Typ	Max	Units
V_{VDDIN_5}	Input voltage range		4.5		5.5	V
V_{VDDIN_33}	Output voltage, calibrated value			3.4		V
I_{OUT}	DC output current				35	mA
I_{VREG}	Static current of regulator	Low power mode		10		µA

7.8.3 1.8V Brown Out Detector (BOD18) Characteristics

The values in Table 7-21 describe the values of the BOD.LEVEL in the SCIF module.

Table 7-21. BODLEVEL Values

BODLEVEL Value	Parameter	Min	Max	Units
0		1.29	1.58	V
20		1.36	1.63	
26	threshold at power-up sequence	1.42	1.69	
28		1.43	1.72	
32		1.48	1.77	
36		1.53	1.82	
40		1.56	1.88	

Table 7-36. ADC and S/H Transfer Characteristics (Continued)10-bit Resolution Mode and S/H gain from 1 to 16[1]

Symbol	Parameter	Conditions	Min	Typ	Max	Units
RES	Resolution	Differential mode, V_{VDDANA} = 5V, $V_{ADCREF0}$ = 3V, ADCFIA.SEQCFGn.SRES = 1, S/H gain from 1 to 16 (F_{adc} = 1.5MHz)			10	Bit
INL	Integral Non-Linearity				1.5	LSB
DNL	Differential Non-Linearity				1.5	LSB
	Offset error		-25		25	mV
	Gain error		-15		15	mV

Note: 1. The measures are done without any I/O activity on VDDANA/GNDANA power domain.

7.8.7 Digital to Analog Converter (DAC) Characteristics

Table 7-37. Channel Conversion Time and DAC Clock

Symbol	Parameter	Conditions	Min	Typ	Max	Units
f_{DAC}	DAC clock frequency				1	MHz
$t_{STARTUP}$	Startup time				3	µs
t_{CONV}	Conversion time (latency)	No S/H enabled, internal DAC			1	µs
		One S/H			1.5	µs
		Two S/H			2	µs
	Throughput rate				$1/t_{CONV}$	MSPS

Table 7-38. External Voltage Reference Input

Symbol	Parameter	Conditions	Min	Typ	Max	Units
V_{DACREF}	DACREF input voltage range		1.2		V_{VDDANA}-0.7	V

Table 7-39. DAC Outputs

Symbol	Parameter	Conditions	Min	Typ	Max	Units
	Output range	with external DAC reference	0.2		V_{DACREF}	V
		with internal DAC reference	0.2		V_{VDDANA}-0.7	
C_{LOAD}	Output capacitance		0		100	pF
R_{LOAD}	Output resitance		2			kΩ

7.9 Timing Characteristics

7.9.1 Startup, Reset, and Wake-up Timing

The startup, reset, and wake-up timings are calculated using the following formula:

$$t = t_{CONST} + N_{CPU} \times t_{CPU}$$

Where t_{CONST} and N_{CPU} are found in Table 7-44. t_{CONST} is the delay relative to RCSYS, t_{CPU} is the period of the CPU clock. If another clock source than RCSYS is selected as CPU clock the startup time of the oscillator, $t_{OSCSTART}$, must be added to the wake-up time in the stop, deepstop, and static sleep modes. Please refer to the source for the CPU clock in the "Oscillator Characteristics" on page 57 for more details about oscillator startup times.

Table 7-44. Maximum Reset and Wake-up Timing

Parameter		Measuring	Max t_{CONST} (in µs)	Max N_{CPU}
Startup time from power-up, using regulator		VDDIN_5 rising (10 mV/ms) Time from V_{VDDIN_5}=0 to the first instruction entering the decode stage of CPU. VDDCORE is supplied by the internal regulator.	2600	0
Startup time from reset release		Time from releasing a reset source (except POR, BOD18, and BOD33) to the first instruction entering the decode stage of CPU.	1240	0
Wake-up	Idle	From wake-up event to the first instruction entering the decode stage of the CPU.	0	19
	Frozen		268	209
	Standby		268	209
	Stop		268+ $t_{OSCSTART}$	212
	Deepstop		268+ $t_{OSCSTART}$	212
	Static		268+ $t_{OSCSTART}$	212

Maximum SPI Frequency, Slave Input Mode

The maximum SPI slave input frequency is given by the following formula:

$$f_{SPCKMAX} = MIN(\frac{f_{CLKSPI} \times 2}{9}, \frac{1}{SPIn})$$

Where $SPIn$ is the MOSI setup and hold time, USPI7 + USPI8 or USPI10 + USPI11 depending on CPOL and NCPHA. f_{CLKSPI} is the maximum frequency of the CLK_SPI. Refer to the SPI chapter for a description of this clock.

Maximum SPI Frequency, Slave Output Mode

The maximum SPI slave output frequency is given by the following formula:

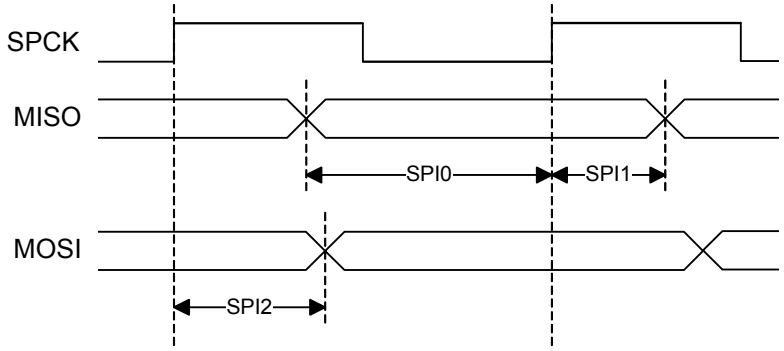
$$f_{SPCKMAX} = MIN(\frac{f_{CLKSPI} \times 2}{9}, f_{PINMAX}, \frac{1}{SPIn + t_{SETUP}})$$

Where $SPIn$ is the MISO delay, USPI6 or USPI9 depending on CPOL and NCPHA. T_{SETUP} is the SPI master setup time. Please refer to the SPI masterdatasheet for T_{SETUP} . f_{CLKSPI} is the maximum frequency of the CLK_SPI. Refer to the SPI chapter for a description of this clock. f_{PINMAX} is the maximum frequency of the SPI pins. Please refer to the I/O Pin Characteristics section for the maximum frequency of the pins.

7.9.4 SPI Timing

7.9.4.1 Master mode

Figure 7-11. SPI Master Mode With (CPOL= NCPHA= 0) or (CPOL= NCPHA= 1)



7.9.9 MACB Characteristics

Table 7-59. Ethernet MAC Signals[1]

Symbol	Parameter	Conditions	Min.	Max.	Unit
MAC_1	Setup for MDIO from MDC rising	V_{VDD} = 3.0V, drive strength of the pads set to the highest, external capacitor = 10pF on MACB pins	0	2.5	ns
MAC_2	Hold for MDIO from MDC rising		0	0.7	ns
MAC_3	MDIO toggling from MDC falling		0	1.1	ns

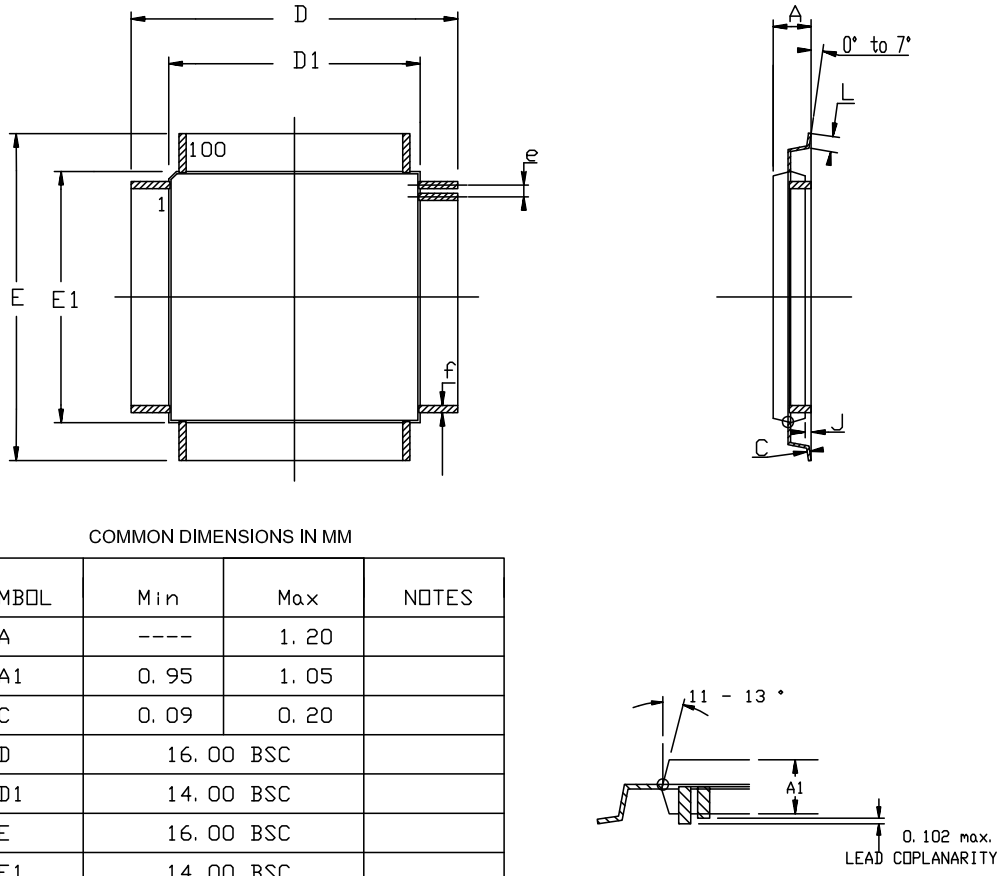
Note: 1. These values are based on simulation and characterization of other AVR microcontrollers manufactured in the same process technology. These values are not covered by test limits in production.

Table 7-60. Ethernet MAC MII Specific Signals[1]

Symbol	Parameter	Conditions	Min.	Max.	Unit
MAC_4	Setup for COL from TX_CLK rising	V_{VDD} = 3.0V, drive strength of the pads set to the highest, external capacitor = 10pF on MACB pins	0		ns
MAC_5	Hold for COL from TX_CLK rising		0		ns
MAC_6	Setup for CRS from TX_CLK rising		0.5		ns
MAC_7	Hold for CRS from TX_CLK rising		0.5		ns
MAC_8	TX_ER toggling from TX_CLK rising		16.4	18.6	ns
MAC_9	TX_EN toggling from TX_CLK rising		14.5	15.3	ns
MAC_{10}	TXD toggling from TX_CLK rising		13.9	18.2	ns
MAC_{11}	Setup for RXD from RX_CLK		1.3		ns
MAC_{12}	Hold for RXD from RX_CLK		1.8		ns
MAC_{13}	Setup for RX_ER from RX_CLK		3.4		ns
MAC_{14}	Hold for RX_ER from RX_CLK		0		ns
MAC_{15}	Setup for RX_DV from RX_CLK		0.7		ns
MAC_{16}	Hold for RX_DV from RX_CLK		1.3n		ns

Note: 1. These values are based on simulation and characterization of other AVR microcontrollers manufactured in the same process technology. These values are not covered by test limits in production.

Figure 8-3. TQFP-100 package drawing



COMMON DIMENSIONS IN MM

SYMBOL	Min	Max	NOTES
A	----	1.20	
A1	0.95	1.05	
C	0.09	0.20	
D	16.00 BSC		
D1	14.00 BSC		
E	16.00 BSC		
E1	14.00 BSC		
J	0.05	0.15	
L	0.45	0.75	
e	0.50 BSC		
f	0.17	0.27	

Table 8-8. Device and Package Maximum Weight

500	mg

Table 8-9. Package Characteristics

Moisture Sensitivity Level	Jdec J-STD0-20D - MSL 3

Table 8-10. Package Reference

JEDEC Drawing Reference	MS-026
JESD97 Classification	E3

10.2 rev D

10.2.1 ADCIFA

1. **ADCREFP/ADCREFN can not be selected as an external ADC reference by setting the ADCIFA.CFG.EXREF bit to one**
   Fix/Workaround
   A voltage reference can be applied on ADCREFP/ADCREFN pins if the ADCIFA.CFG.EXREF bit is set to zero, the ADCIFA.CFG.RS bit is set to zero and the voltage reference applied on ADCREFP/ADCREFN pins is higher than the internal 1V reference.

10.2.2 AST

1. **AST wake signal is released one AST clock cycle after the BUSY bit is cleared**
   After writing to the Status Clear Register (SCR) the wake signal is released one AST clock cycle after the BUSY bit in the Status Register (SR.BUSY) is cleared. If entering sleep mode directly after the BUSY bit is cleared the part will wake up immediately.
   Fix/Workaround
   Read the Wake Enable Register (WER) and write this value back to the same register. Wait for BUSY to clear before entering sleep mode.

10.2.3 aWire

1. **aWire MEMORY_SPEED_REQUEST command does not return correct CV**
   The aWire MEMORY_SPEED_REQUEST command does not return a CV corresponding to the formula in the aWire Debug Interface chapter.
   Fix/Workaround
   Issue a dummy read to address 0x100000000 before issuing the MEMORY_SPEED_REQUEST command and use this formula instead:

$$f_{sab} = \frac{7 f_{aw}}{CV - 3}$$

10.2.4 GPIO

1. **Clearing Interrupt flags can mask other interrupts**
   When clearing interrupt flags in a GPIO port, interrupts on other pins of that port, happening in the same clock cycle will not be registered.
   Fix/Workaround
   Read the PVR register of the port before and after clearing the interrupt to see if any pin change has happened while clearing the interrupt. If any change occurred in the PVR between the reads, they must be treated as an interrupt.

10.2.5 Power Manager

1. **Clock Failure Detector (CFD) can be issued while turning off the CFD**
   While turning off the CFD, the CFD bit in the Status Register (SR) can be set. This will change the main clock source to RCSYS.
   Fix/Workaround
   Solution 1: Enable CFD interrupt. If CFD interrupt is issues after turning off the CFD, switch back to original main clock source.
   Solution 2: Only turn off the CFD while running the main clock on RCSYS.

10.2.10 TWIS

1. **Clearing the NAK bit before the BTF bit is set locks up the TWI bus**
When the TWIS is in transmit mode, clearing the NAK Received (NAK) bit of the Status Register (SR) before the end of the Acknowledge/Not Acknowledge cycle will cause the TWIS to attempt to continue transmitting data, thus locking up the bus.
Fix/Workaround
Clear SR.NAK only after the Byte Transfer Finished (BTF) bit of the same register has been set.

2. **TWIS stretch on Address match error**
When the TWIS stretches TWCK due to a slave address match, it also holds TWD low for the same duration if it is to be receiving data. When TWIS releases TWCK, it releases TWD at the same time. This can cause a TWI timing violation.
Fix/Workaround
None.

3. **TWALM forced to GND**
The TWALM pin is forced to GND when the alternate function is selected and the TWIS module is enabled.
Fix/Workaround
None.

10.2.11 USBC

1. **UPINRQx.INRQ field is limited to 8-bits**
In Host mode, when using the UPINRQx.INRQ feature together with the multi-packet mode to launch a finite number of packet among multi-packet, the multi-packet size (located in the descriptor table) is limited to the UPINRQx.INRQ value multiply by the pipe size.
Fix/Workaround
UPINRQx.INRQ value shall be less than the number of configured multi-packet.

2. **In USB host mode, downstream resume feature does not work (UHCON.RESUME=1).**
Fix/Workaround
None.

3. **In host mode, the disconnection during OUT transition is not supported**
In USB host mode, a pipe can not work if the previous USB device disconnection has occurred during a USB transfer.
Fix/Workaround
Reset the USBC (USBCON.USB=0 and =1) after a device disconnection (UHINT.DDISCI).

4. **In USB host mode, entering suspend mode can fail**
In USB host mode, entering suspend mode can fail when UHCON.SOFE=0 is done just after a SOF reception (UHINT.HSOFI).
Fix/Workaround
Check that UHNUM.FLENHIGH is below 185 in Full speed and below 21 in Low speed before clearing UHCON.SOFE.

5. **In USB host mode, entering suspend mode for low speed device can fail when the USB freeze (USBCON.FRZCLK=1) is done just after UHCON.SOFE=0.**
Fix/Workaround
When entering suspend mode (UHCON.SOFE is cleared), check that USBFSM.DRDSTATE is not equal to three before freezing the clock (USBCON.FRZCLK=1).

Headquarters

Atmel Corporation
2325 Orchard Parkway
San Jose, CA 95131
USA
Tel: 1(408) 441-0311
Fax: 1(408) 487-2600

International

Atmel Asia
Unit 1-5 & 16, 19/F
BEA Tower, Millennium City 5
418 Kwun Tong Road
Kwun Tong, Kowloon
Hong Kong
Tel: (852) 2245-6100
Fax: (852) 2722-1369

Atmel Europe
Le Krebs
8, Rue Jean-Pierre Timbaud
BP 309
78054 Saint-Quentin-en-
Yvelines Cedex
France
Tel: (33) 1-30-60-70-00
Fax: (33) 1-30-60-71-11

Atmel Japan
9F, Tonetsu Shinkawa Bldg.
1-24-8 Shinkawa
Chuo-ku, Tokyo 104-0033
Japan
Tel: (81) 3-3523-3551
Fax: (81) 3-3523-7581

Product Contact

Web Site
www.atmel.com

Technical Support
avr32@atmel.com

Sales Contact
www.atmel.com/contacts

Literature Requests
www.atmel.com/literature